













**TLC5973** 

SBVS225B - MARCH 2013-REVISED MAY 2014

# TLC5973 3-Channel, 12-Bit, PWM Constant-Current LED Driver with Single-Wire Interface (EasySet™)

#### **Features**

- Three Constant Sink Current Channels
- **Current Capability:** 
  - 2 mA to 35 mA per Channel (VCC ≤ 4.0 V)
  - 2 mA to 50 mA per Channel (VCC > 4.0 V)
- Grayscale (GS) Control with PWM:
  - 12-Bit (4096 Steps)
- Single-Wire Interface (EasySet)
- Power-Supply (VCC) Voltage Range:
  - 3 V to 6 V
- OUT Pins Maximum Voltage: Up to 21 V
- Integrated Shunt Regulator
- Data Transfer Maximum Rate:
  - Bits per Second (bps): 3 Mbps
- Internal GS Clock Oscillator: 12 MHz (typ)
- Display Repeat Rate: 2.9 kHz (typ)
- Output Delay Switching to Prevent Inrush Current
- **Unlimited Device Cascading**
- Operating Temperature: -40°C to 85°C

## 2 Applications

This device is targeted towards one application. The primary application for this device is for RGB LED cluster lamp displays.

## 3 Description

The TLC5973 is an easy-to-use, 3-channel, 50-mA constant sink current LED driver. The single-wire, 3-Mbps serial interface (EasySet) provides a solution for minimizing wiring cost. The LED driver provides 12-bit pulse width modulation (PWM) resolution. The display repeat rate is achieved at 2.9 kHz (typ) with an integrated 12-MHz grayscale (GS) clock oscillator. The driver also provides unlimited cascading capability.

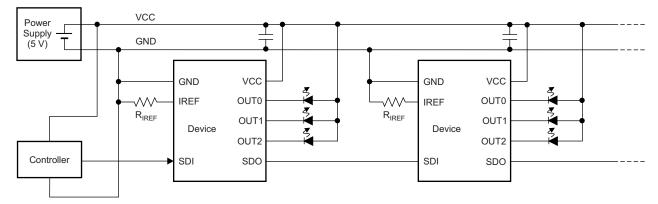
All output sink constant currents can be set by an external resistor. The TLC5973 has an internal shunt regulator that can be used for higher VCC powersupply voltage applications.

#### Device Information<sup>(1)</sup>

DEVICE NAME	PACKAGE	BODY SIZE	
TLC5973	SOIC (8)	4.9 mm × 3.91 mm	

(1) For all available packages, see the orderable addendum at the end of the datasheet.

## Typical Application Circuit Example





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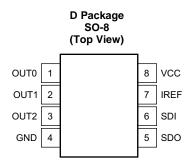
# 4 Revision History

Changes from Revision A (May 2013) to Revision B

Cl	nanges from Revision A (May 2013) to Revision B	Page
•	Changed format to meet latest data sheet standards; added Applications and Implementation, Power Supply Recommendations, and Layout sections, moved existing sections	1
•	Changed 8-bit pulse width modulation to 12-bit pulse width modulation in Description section	1
•	Changed t <sub>H0</sub> and t <sub>H1</sub> parameter units from µs to ns in Recommended Operating Conditions table	4
•	Changed Figure 8: deleted top SDO, changed bottom SDO to OUTn	<mark>7</mark>
•	Changed Figure 11: deleted extraneous breaks in traces, extraneous data call-outs, and t <sub>H1</sub> on GSLAT trace, changed data transfer trace note to <i>Internal to 1st Device</i> and 1st Data to 47th Data in 48-Bit Shift Register LSB traces.	ace 9
•	Changed functional block diagram: changed Upper 8 Bits to Upper 12 Bits on 48-Bit Shift Register block	11
•	Added Grayscale (GS) Control, EasySet and Shunt Regulator, and No Limit Cascading sections	11
•	Changed Connector Design title	13
•	Changed Figure 13: changed OUTn traces GSDATA = 4093 and GSDATA = 4094	15
•	Changed description of the Data '0' and Data '1' Write Sequence (Data Write Sequence) section	16
•	Changed title of Controlling Devices Connected in Series section	19
•	Changed Data 101 to Data 1010 in Figure 18	19
•	Changed eight MSBs to 12 MSBs in third sentence of the Register and Data Latch Configuration section	21
•	Changed Figure 21: corrected 3AAh bit set sequence	21
•	Changed Figure 26: changed number of LEDs in optional dashed box	26
<u>.</u>	Changed Table 7: changed all values in $R_{VCC}$ column and first and last values in $Resistor\ Wattage\ column\$	27
CI	nanges from Original (March 2013) to Revision A	Page
•	Changed second paragraph of Grayscale (GS) Function (PWM Control) section	13
•	Changed t <sub>CYCLE</sub> setting range in <i>Data Transfer Rate</i> (t <sub>CYCLE</sub> ) Measurement Sequence section	16



## 5 Pin Configuration and Functions



#### **Pin Functions**

PIN			
NAME	NO.	1/0	DESCRIPTION
OUT0	1	0	Constant sink current driver outputs.
OUT1	2	0	Multiple outputs can be configured in parallel to increase the sink drive current capability.
OUT2	3	0	Different voltages can be applied to each output.
GND	4	_	Power ground
SDO	5	0	Serial data output
SDI	6	- 1	Serial data input. This pin is internally pulled down to GND with a 1-M $\Omega$ (typ) resistor.
IREF	7	I/O	Output current programming pin. A resistor connected between IREF and GND sets the current for each constant-current output. Place the external resistor close to the device.
VCC	8	_	Power-supply voltage

# 6 Specifications

# 6.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
	Supply, V <sub>CC</sub>	VCC	-0.3	7.0	V
Voltage <sup>(2)</sup>	Input range, V <sub>IN</sub>	SDI	-0.3	V <sub>CC</sub> + 1.2	V
Voltage (=)	Output range, V <sub>OUT</sub>	OUT0 to OUT2	-0.3	21	V
		SDO	-0.3	7.0	V
Current	Output (dc), I <sub>OUT</sub>	OUT0 to OUT2	0	60	mA
Operating junction temperature, T <sub>J</sub>			-40	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods my affect device reliability.

(2) All voltages are with respect to network ground pin.

## 6.2 Handling Ratings

			MIN	MAX	UNIT
T <sub>stg</sub>	Storage temperature rang	ge	<del>-</del> 55	150	°C
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	-8000	8000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	-2000	2000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



# 6.3 Recommended Operating Conditions

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
DC CHARA	ACTERISTICS		1			
V	Cupply voltage	No internal shunt regulator mode	3.0	5.0	5.5	V
V <sub>CC</sub>	Supply voltage	Internal shunt regulator mode			6.0	V
Vo	Voltage applied to output	OUT0 to OUT2			21	V
V <sub>IH</sub>	High-level input voltage	SDI	$0.7 \times V_{CC}$		$V_{CC}$	V
V <sub>IL</sub>	Low-level input voltage	SDI	GND		$0.3 \times V_{CC}$	V
V <sub>IHYST</sub>	Input voltage hysteresis	SDI		0.2 × V <sub>CC</sub>		V
I <sub>OH</sub>	High-level output current	SDO			-2	mA
		SDO			2	mA
I <sub>OL</sub>	Low-level output current	OUT0 to OUT2 (VCC ≤ 4.0 V)	2		35	mA
		OUT0 to OUT2 (VCC > 4.0 V)	2		50	mA
I <sub>REG</sub>	Shunt regulator sink current	VCC			20	mA
T <sub>A</sub>	Operating free-air temperature range		-40		85	°C
$T_{J}$	Operating junction temperature range		-40		125	°C
AC CHARA	ACTERISTICS		•			
f <sub>CLK</sub> (SDI)	Data transfer rate	SDI	100		3000	kHz
t <sub>SDI</sub>	SDI input pulse duration	SDI	60		0.5 / f <sub>CLK</sub>	ns
t <sub>WH</sub>	Pulse duration, high	SDI	14			ns
t <sub>WL</sub>	Pulse duration, low	SDI	14			ns
t <sub>H0</sub>	Hold time: end of sequence (EOS)	SDI↑ to SDI↑	3.5 / f <sub>CLK</sub>		5.5 / f <sub>CLK</sub>	ns
t <sub>H1</sub>	Hold time: data latch (GSLAT)	SDI↑ to SDI↑	8 / f <sub>CLK</sub>			ns

## 6.4 Thermal Information

		TLC5973	
	THERMAL METRIC <sup>(1)</sup>	D (SO)	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	134.6	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	88.6	
$R_{\theta JB}$	Junction-to-board thermal resistance	75.3	90044
ΨЈТ	Junction-to-top characterization parameter	37.7	°C/W
ΨЈВ	Junction-to-board characterization parameter	74.8	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



#### 6.5 Electrical Characteristics

At  $T_A = -40^{\circ}\text{C}$  to 85°C,  $V_{CC} = 3$  V to 6.0 V, and  $C_{VCC} = 0.1~\mu\text{F}$ . Typical values at  $T_A = 25^{\circ}\text{C}$  and  $V_{CC} = 5.0$  V, unless otherwise

	PARAMETER	TEST CON	IDITIONS	MIN	TYP	MAX	UNIT
V <sub>OH</sub>	High-level output voltage (SDO)	I <sub>OH</sub> = −2 mA		V <sub>CC</sub> - 0.4		V <sub>CC</sub>	V
V <sub>OL</sub>	Low-level output voltage (SDO)	I <sub>OL</sub> = 2 mA		0		0.4	V
V <sub>IREF</sub>	Reference voltage output	$R_{IREF} = 1.5 \text{ k}\Omega$		1.18	1.20	1.23	V
$V_R$	Shunt regulator output voltage (V <sub>CC</sub> )	I <sub>CC</sub> = 1 mA, SDI = low			5.9		V
I <sub>CC0</sub>		$V_{CC}$ = 3.0 V to 5.5 V , SDI = low FFFh, $V_{OUTn}$ = 1 V, SDO = 15 p ( $I_{OUTn}$ = 2-mA target)			3	6	mA
I <sub>CC1</sub>	Cumbia current (V.)	$V_{CC}$ = 3.0 V to 5.5 V, SDI = low, all grayscale (GSn) = FFFh, $V_{OUTn}$ = 1 V, SDO = 15 pF, $R_{IREF}$ = 3 k $\Omega$ ( $I_{OUTn}$ = 17-mA target)			4	7	mA
I <sub>CC2</sub>	Supply current (V <sub>CC</sub> )	FFFh, V <sub>OUTn</sub> = 1 V, SDO = 15 p	$\begin{split} &V_{\text{CC}} = 3.0 \text{ V to } 5.5 \text{ V, SDI} = 5 \text{ MHz, all grayscale (GS}\textit{n}) = \\ &\text{FFFh, } V_{\text{OUTn}} = 1 \text{ V, SDO} = 15 \text{ pF,} \\ &R_{\text{IREF}} = 3 \text{ k}\Omega \text{ (}l_{\text{OUTn}} = 17\text{-mA target)} \\ &V_{\text{CC}} = 3.0 \text{ V to } 5.5 \text{ V, SDI} = 5 \text{ MHz, all grayscale (GS}\textit{n}) = \\ &\text{FFFh, } V_{\text{OUTn}} = 1 \text{ V, SDO} = 15 \text{ pF,} \\ &R_{\text{IREF}} = 1.5 \text{ k}\Omega \text{ (}l_{\text{OUTn}} = 34\text{-mA target)} \end{split}$		5	8	mA
I <sub>CC3</sub>		FFFh, V <sub>OUTn</sub> = 1 V, SDO = 15 p			5.5	10	mA
I <sub>OLC</sub>	Constant output current (OUT0 to OUT2)	All OUT $n$ = on, $V_{OUTn}$ = 1 V, $V_{O}$ R <sub>IREF</sub> = 1.5 k $\Omega$	$p_{\text{UTfix}} = 1 \text{ V},$	31	34	37	mA
I	Output leakage current	GS <i>n</i> = 000h, V <sub>OUTn</sub> = 21 V	$T_J = -40$ °C to 85°C			0.1	μΑ
I <sub>OLKG</sub>	(OUT0 to OUT2)	G377 = 00011, V <sub>OUTn</sub> = 21 V	$T_J = 85^{\circ}C$ to $125^{\circ}C$			0.2	μΑ
$\Delta I_{OLC0}$	Constant-current error (channel-to-channel) <sup>(1)</sup>	All OUT $n = \text{on}$ , $V_{\text{OUT}n} = V_{\text{OUTfix}}$	= 1 V, $R_{IREF}$ = 1.5 k $\Omega$		±0.5%	±3%	
$\Delta I_{OLC1}$	Constant-current error (device-to-device) (2)	All OUT $n = \text{on}$ , $V_{\text{OUT}n} = V_{\text{OUTfix}}$	= 1 V, R <sub>IREF</sub> = 1.5 kΩ		±0.5%	±6%	
$\Delta I_{OLC2}$	Line regulation of constant-current output (3)	All OUT $n$ = on, $V_{OUTn}$ = $V_{OUTfix}$ = 1 V, $R_{IREF}$ = 1.5 k $\Omega$			±0.5	±1	%/V
$\Delta I_{OLC3}$	Load regulation of constant-current output (4)	All OUT $n = \text{on}$ , $V_{\text{OUT}n} = V_{\text{OUTfix}}$	= 1 V, R <sub>IREF</sub> = 1.5 kΩ		±0.5	±1	%/V
R <sub>PD</sub>	Internal pull-down resistance (SDI)	At SDI			1		MΩ

(1) The deviation of each output (OUT0 to OUT2) from the constant-current average. Deviation is calculated by the formula:

$$\Delta \text{ (\%)} = \left[ \frac{\frac{I_{\text{OUT}n}}{I_{\text{OUT}0} + I_{\text{OUT}1} + I_{\text{OUT}2}}} - 1 \right] \times 100$$

Deviation of the constant-current average in each color group from the ideal constant-current value. Deviation is calculated by the

$$\Delta \text{ (\%) = } \left[ \begin{array}{c} I_{\text{OUT0}} + I_{\text{OUT1}} + I_{\text{OUT2}} \\ \hline 3 \end{array} \right] - \text{Ideal Output Current}$$

$$| \text{Ideal Output Current} | \times 100 \text{ Ideal Output Current} | \times$$

Ideal current is calculated by the formula:

$$I_{OUTn(IDEAL)}$$
 (mA) = 43.4 ×  $\left[\frac{1.20}{R_{IREF}(\Omega)}\right]$ 

where n = 0 to 2.

(3) Line regulation is calculated by the formula:  

$$\Delta (\%/V) = \left(\frac{(I_{OUT_n} \text{ at V}_{CC} = 5.5 \text{ V}) - (I_{OUT_n} \text{ at V}_{CC} = 3.0 \text{ V})}{I_{OUT_n} \text{ at V}_{CC} = 3.0 \text{ V}}\right) \times \frac{100}{5.5 \text{ V} - 3.0 \text{ V}}$$

where n = 0 to 2.

Load regulation is calculated by the equation:  

$$\Delta (\%/V) = \left\{ \frac{(I_{OUT_n} \text{ at } V_{OUT_n} = 3.0 \text{ V}) - (I_{OUT_n} \text{ at } V_{OUT_n} = 1.0 \text{ V})}{I_{OUT_n} \text{ at } V_{OUT_n} = 1.0 \text{ V}} \right\} \times \frac{100}{3.0 \text{ V} - 1.0 \text{ V}}$$

, where n = 0 to 2.



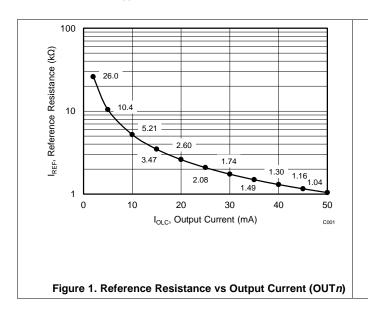
## 6.6 Switching Characteristics

At  $T_A = -40$ °C to 85°C,  $V_{CC} = 3.0$  V to 5.5 V,  $C_L = 15$  pF,  $R_L = 110$   $\Omega$ , and  $V_{LED} = 5.0$  V, unless otherwise noted. Typical values are at  $T_A = 25$ °C and  $V_{CC} = 5.0$  V.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>R0</sub>	Rise time	SDO	2	6	12	ns
t <sub>R1</sub>	Rise time	$OUTn$ (on $\rightarrow$ off)		200	400	ns
t <sub>F0</sub>	Fall time	SDO	2	6	12	ns
t <sub>F1</sub>	Fall time	$OUTn$ (off $\to$ on)		200	400	ns
t <sub>D0</sub>		SDI↑ to SDO↑		30	50	ns
t <sub>D1</sub>	Propagation delay	OUT0↓ to OUT1↓, OUT1↓to OUT2↓, OUT0↑ to OUT1↑, OUT1↑to OUT2↑		25		ns
t <sub>WO</sub>	Shift data output one pulse duration	SDO↑ to SDO↓	15	25	45	ns
fosc	Internal GS oscillator frequency		8	12	16	MHz

## 6.7 Typical Characteristics

At  $T_A = 25$ °C and  $V_{CC} = 12$  V, unless otherwise noted.



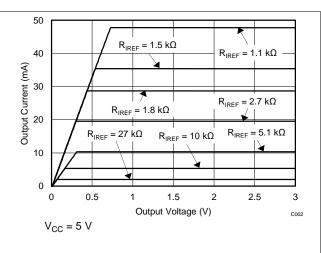


Figure 2. Output Current vs Output Voltage (OUTn)

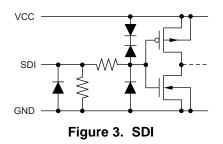
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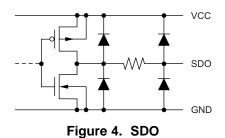
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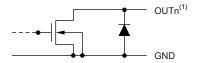


## 7 Parameter Measurement Information

## 7.1 Pin-Equivalent Input and Output Schematic Diagrams



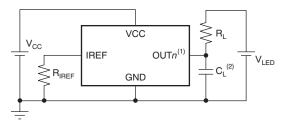




(1) n = 0 to 2.

Figure 5. OUT0 Through OUT2

## 7.2 Test Circuits



- (1) n = 0 to 2.
- (2) C<sub>L</sub> includes measurement probe and jig capacitance.

V<sub>CC</sub> VCC IREF SDO C<sub>L</sub><sup>(1)</sup>

Figure 7. Rise and Fall Time Test Circuit for SDO

(1) C<sub>L</sub> includes measurement probe and jig capacitance.

Figure 6. Rise and Fall Time Test Circuit for OUT*n* 

V<sub>CC</sub>

| Ref | OUTn<sup>(1)</sup>
| OUTn | V<sub>OUTfix</sub> | V<sub>OUTfix</sub>

(1) n = 0 to 2.

Figure 8. Constant-Current Test Circuit for OUTn

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# TEXAS INSTRUMENTS

# 7.3 Timing Diagrams

 $t_{WH}$ ,  $t_{WL}$ SDI<sup>(1)</sup> 50%  $t_{WH}$   $t_{WL}$ 1st Data of Next Device ( $t_{H0}$  case) or 1st Data of Next Sequence ( $t_{H1}$  case).

V<sub>CC</sub>

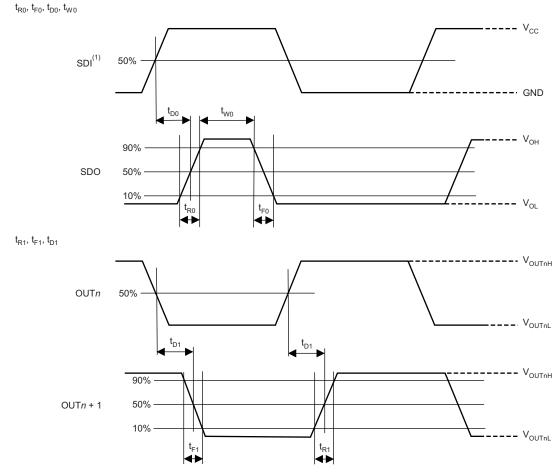
SDI<sup>(1)</sup> 50%

GND

(1) Input pulse rise and fall time is 1 ns to 3 ns.

Figure 9. Input Timing

 $t_{\rm H0},\,t_{\rm H1}$ 

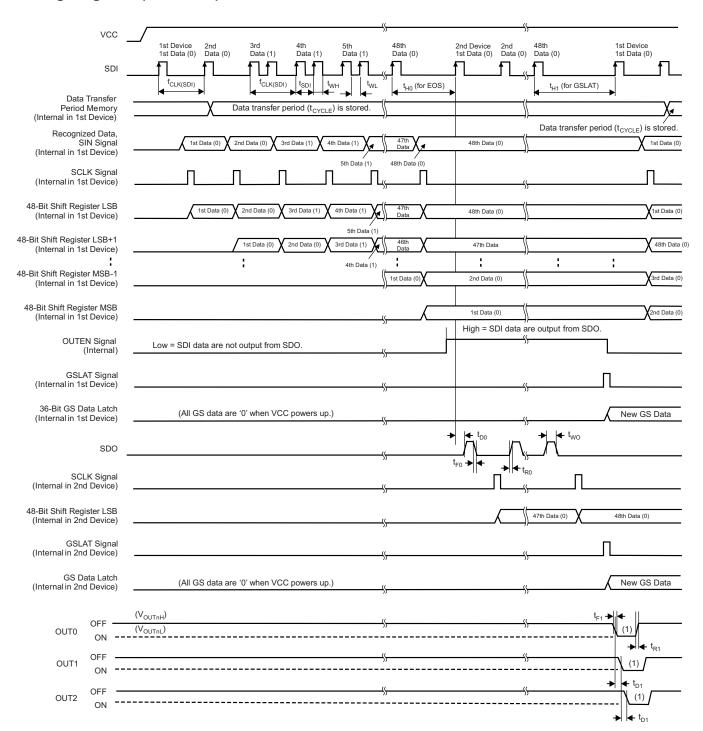


(1) Input pulse rise and fall time is 1 ns to 3 ns.

Figure 10. Output Timing



## **Timing Diagrams (continued)**



(1) OUTn on-time changes, depending on the data in the 36-bit GS data latch.

Figure 11. Data Write and OUTn Switching Timing



## 8 Detailed Description

#### 8.1 Overview

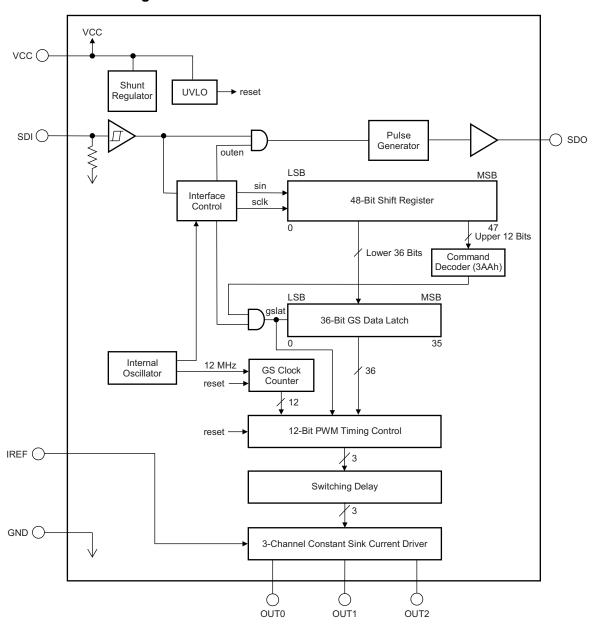
The TLC5973 is 3-channel, 50-mA, constant-current LED driver that can control LED on-time with pulse width modulation (PWM) in 4096 steps for grayscale (GS) control. A maximum of 68 billion colors can be generated with red, green, and blue LEDs connected to each constant-current output. Furthermore, a reference clock generator is implemented in the device, which means that the reference clock for PWM timing control is not required to be supplied from an external clock generator or controller.

The device adopts a single-wire input or output system. Therefore, communication wire cost and communication wire failure are reduced. Further wire cost reduction can be attained when supplying power to the device. One wire can be eliminated because the device power can be generated from the LED power line with the internal shunt regulator.

The device can reduce the amount of incorrect data writes because the one-write command is required to write GS data to the device. The maximum data transfer rate for the device is 3 Mbps. Therefore, GS data can be updated with a high refresh rate even if many devices are connected in series. The number of TLC5973 devices connected in series is not limited because the TLC5973 has an internal buffer that drives the output signal.



### 8.2 Functional Block Diagram



## 8.3 Feature Description

## 8.3.1 Grayscale (GS) Control

This control feature is a 12-bit (4096-step) grayscale (GS) control that provides a wide range of color generation. 68 billion colors can be generated with the red, green, and blue LEDs. Connect the LEDs to the device OUT*n* pins, as described in the *Applications and Implementation* section.

#### 8.3.2 EasySet and Shunt Regulator

This device includes a single-wire serial interface (EasySet) and a shunt regulator. The total number of wires for power supply and data write operations can be reduced with the EasySet and shunt regulator included in the design.



## **Feature Description (continued)**

#### 8.3.3 No Limit Cascading

This feature results in no limitation on the number of total cascaded devices used in series in an application. This advantage is attained because a timing-adjusted pulse generator is implemented in the device.

#### 8.3.4 Constant Sink Current Value

The output current value of each channel ( $I_{OLC}$ ) is programmed by a single resistor ( $R_{IREF}$ ) that is placed between the IREF and GND pins. The current value can be calculated by Equation 1:

$$R_{\text{IREF}}\left(k\Omega\right) = \frac{V_{\text{IREF}}\left(V\right)}{I_{\text{OLC}}\left(mA\right)} \times 43.4$$

where:

• V<sub>IREF</sub> = the internal reference voltage on IREF (typically 1.20 V), and

 $I_{OLC}$  is the current for each output. Each output sinks  $I_{OLC}$  current when it is turned on.  $R_{IREF}$  must be between 1 k $\Omega$  and 27 k $\Omega$  in order to hold  $I_{OLC}$  between 50 mA (typ) and 1.93 mA (typ). Otherwise, the output may be unstable. Refer to Figure 1 and Table 1 for the constant-current sink values for specific external resistor values.

Table 1. Constant-Current Output versus External Resistor Value

I <sub>OLC</sub> (mA)	$R_{IREF}$ (k $\Omega$ , typ)
50	1.04
45	1.16
40	1.30
35	1.49
30	1.74
25	2.08
20	2.60
15	3.47
10	5.21
5	10.4
2	26.0

Product Folder Links: TLC5973

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#### 8.3.5 Connector Design

When the connector pin of the device application printed circuit board (PCB) is connected or disconnected to other PCBs, the power must be turned off to avoid device malfunction or failure. Furthermore, designing the connector GND pin to be longer than other pins (as shown in Figure 12) is preferable. This arrangement allows the GND line to either be connected first or disconnected last, which is imperative for proper device function.

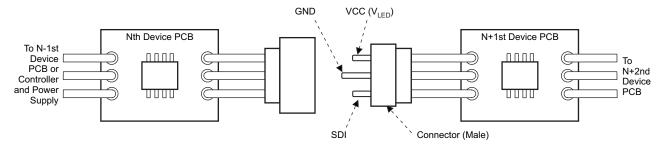


Figure 12. Connector Pin Design Application

#### 8.4 Device Functional Modes

#### 8.4.1 Grayscale (GS) Function (PWM Control)

The TLC5973 can adjust the brightness of each output channel using a pulse width modulation (PWM) control scheme. The PWM data bit length for each output is 12 bits. The architecture of 12 bits per channel results in 4096 brightness steps, from 0% to 99.98% on-time duty cycle.

The PWM operation for OUT*n* is controlled by an 12-bit grayscale (GS) counter. The GS counter increments on each internal GS clock (GSCLK) rising edge. All OUT*n* are turned on when the GS counter is '1', except when OUT*n* are programed to GS data '0' in the 36-bit GS data latch. After turning on, each output is turns off when the GS counter value exceeds the programmed GS data for the output. The GS counter resets to 000h and all outputs are forced off when the GS data are written to the 36-bit GS data latch. Afterwards, the GS counter begins incrementing and PWM control is started from the next internal GS clock.



## **Device Functional Modes (continued)**

Table 2 summarizes the GS data values versus the output ideal on-time duty cycle. Furthermore, actual on-time differs from the ideal on-time because the output drivers and control circuit have some timing delay. When the device is powered on, all outputs are forced off and remain off until the non-zero GS data are written to the 36-bit GS data latch.

Table 2. Output Duty Cycle and Total On-Time versus GS Data

GS DATA		NO. OF GSCLKs NO. OF GSCLKs 1		TOTAL IDEAL TIME	
DECIMAL	HEX	OUT TURNS ON	OUT TURNS OFF	(µs)	ON-TIME DUTY (%)
0	0	Off	Off	0	0
1	1	1	2	0.08	0.02
2	2	1	3	0.17	0.05
_	_	_	_	_	_
255	0FE	1	256	21.25	6.23
256	0FF	1	257	21.33	6.25
257	100	1	258	21.42	6.27
_	_		_	_	_
511	1FF	1	512	42.58	12.48
512	200	1	513	42.67	12.50
513	201	1	514	42.75	12.52
_	_	_	_	_	_
1023	3FF	1	1024	85.25	24.98
1024	400	1	1025	85.33	25.00
1025	401	1	1026	85.42	25.00
_	_		_	_	_
2047	7FF	1	2048	170.6	49.98
2048	800	1	2049	170.7	50.00
2049	801	1	2050	170.8	50.02
_	_		_	_	_
4093	FFD	1	4094	341.1	99.93
4094	FFE	1	4095	341.2	99.95
4095	FFF	1	4096	341.3	99.98

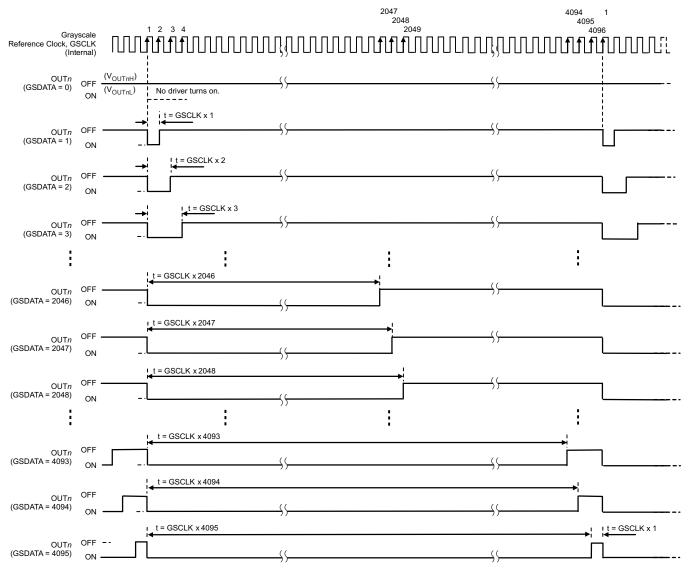
Product Folder Links: *TLC5973* 

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#### 8.4.1.1 PWM Control

The GS counter keeps track of the number of grayscale reference clocks (GSCLKs) from the internal oscillator. Each output stays on while the counter is less than or equal to the programmed GS value. Each output turns off when the GS counter is greater than the GS value in the 36-bit GS data latch. Figure 13 illustrates the PWM operation timing.



(1) Actual on-time differs from the ideal on-time.

Figure 13. PWM Operation

#### 8.4.2 One-Wire Interface (EasySet) Data Writing Method

There are four sequences to write GS data into the TLC5973 via a single-wire interface. This section discusses each sequence in detail.

#### 8.4.2.1 Data Transfer Rate ( $t_{CYCLF}$ ) Measurement Sequence

The TLC5973 measures the time between the first and second SDI rising edges either after the device is powered up or when the GS data latch sequence is executed (as described in the GS Data Latch Sequence (GSLAT) section) and the time is internally stored as  $t_{CYCLE}$ .  $t_{CYCLE}$  serves as a base time used to recognize one complete data write operation, a 48-bit data write operation, and a GS data write operation to the GS data latch.  $t_{CYCLE}$  can be set between 0.33  $\mu$ s and 10  $\mu$ s ( $t_{CLK(SDI)}$ ) = 100 kHz to 3000 kHz). In this sequence, two instances of data '0' are written to the LSB side of the 48-bit shift register. Figure 14 shows the  $t_{CYCLE}$  measurement timing.

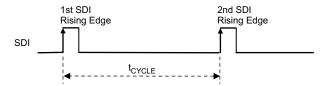


Figure 14. Data Transfer Rate (t<sub>CYCLE</sub>) Measurement

#### 8.4.2.2 Data '0' and Data '1' Write Sequence (Data Write Sequence)

When the second SDI rising edge is not input before  $0.9 \times t_{CYCLE}$  elapses from the first SDI rising edge input, the data are recognized as '0'. When the second SDI rising edge is input before 50% of  $t_{CYCLE}$  elapses from the first SDI rising edge input, the data are recognized as '1'. This write sequence must be repeated 46 times after the  $t_{CYCLE}$  measurement sequence in order to send the write command to the higher 10-bit (3AAh) and 36-bit GS data. Figure 15 shows the data '0' and '1' write timing.

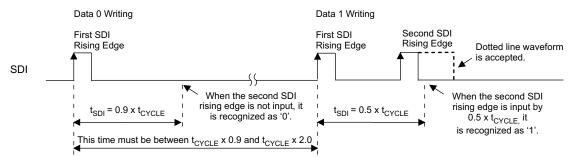


Figure 15. Data '0' and '1' Write Operation



## 8.4.2.3 One Communication Cycle End of Sequence (EOS)

One communication cycle end of sequence (EOS) must be input after the 48-bit data are written because the TLC5973 does not count the number of input data. When SDI is held low for the EOS hold time (t<sub>H0</sub>), the 48-bit shift register values are locked and a buffered SDI signal is output from SDO to transfer GS data to the next device. Figure 16 shows the EOS timing.

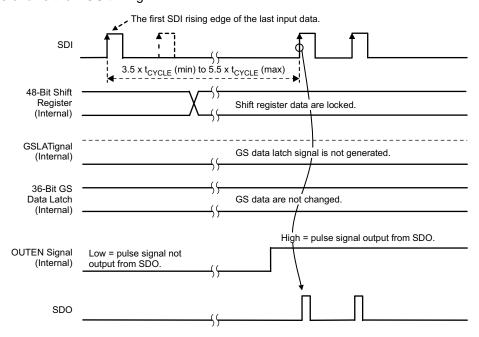


Figure 16. End of Sequence (EOS)



#### 8.4.2.4 GS Data Latch (GSLAT) Sequence

A GS data latch (GSLAT) sequence must be input after the 48-bit data for all cascaded devices are written. When SDI is held low for the data latch hold time ( $t_{H1}$ ), the 48-bit shift register data in all devices are copied to the GS data latch in each device. Furthermore, PWM control starts with the new GS data at the same time. Figure 17 shows the GSLAT timing.

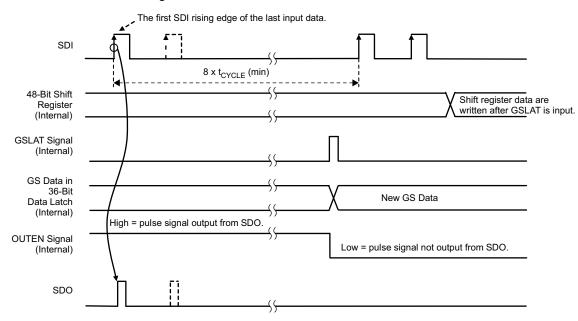


Figure 17. GS Data Latch Sequence (GSLAT)

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### 8.5 Programming

## 8.5.1 Controlling Devices Connected in Series

The 12-bit write command and 36-bit grayscale (GS) data for OUT0 to OUT2 (for a total of 48 bits of data) must be written to the device. Figure 18 shows the 48-bit data packet configuration. When multiple devices are cascaded (as shown in Figure 19), *N* times the packet must be written into each TLC5973 in order to control all devices. There is no limit on how many devices can be cascaded, as long as proper VCC voltage is supplied. The packet for all devices must be written again whenever any GS data changes.

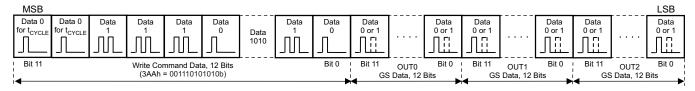


Figure 18. 48-Bit Data Packet Configuration for One TLC5973

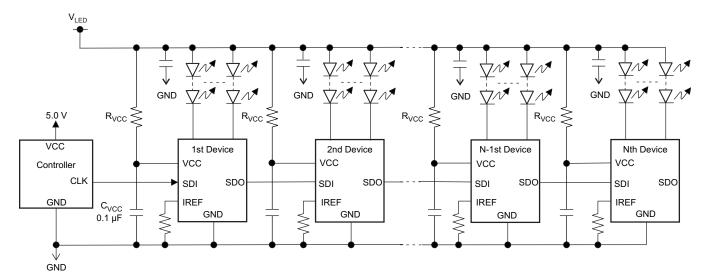


Figure 19. Cascade Connection of NTLC5973 Units (Internal Shunt Regulator Mode)



### **Programming (continued)**

The function setting write procedure and display control is:

- 1. Power-up VCC ( $V_{LED}$ ); all OUTn are off because GS data are not written yet.
- 2. Write the 48-bit data packet (MSB-first) for the first device using t<sub>CYCLE</sub> and the data write sequences illustrated in Figure 14 and Figure 15. The first 12 bits of the 48-bit data packet are used as the write command. The write command must be 3AAh (001110101010b); otherwise, the 36-bit GS data in the 48-bit shift register are not copied to the 36-bit GS data latch.
- 3. Execute one communication cycle EOS (refer to Figure 16) for the first device.
- 4. Write the 48-bit data packet for the second TLC5973 as described step 2. However, t<sub>CYCLE</sub> should be set to the same timing as the first device.
- 5. Execute one communication cycle EOS for the second device.
- 6. Repeat steps 4 and 5 until all devices have GS data.
- 7. The number of total bits is 48 × N. After all data are written, execute a GSLAT sequence as described in Figure 17 in order to copy the 36-bit LSBs in the 48-bit shift resister to the 36-bit GS data latch in each device; PWM control starts with the written GS data at the same time.

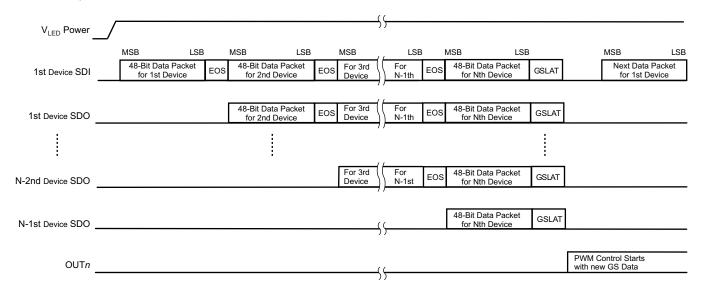


Figure 20. Data Packet Input Order for NTLC5973 Units



#### 8.6 Register Maps

## 8.6.1 Register and Data Latch Configuration

The TLC5973 has a 48-bit shift register and a 36-bit data latch that stores GS data. When the internal GS data latch pulse is generated and the data of the 12 MSBs in the shift register are 3AAh, the lower 36-bit data in the 48-bit shift register are copied into the 36-bit GS data latch. If the data of the 12 MSBs is not 3AAh, the 36-bit data are not copied into the 36-bit GS data latch. Figure 21 shows the shift register and GS data latch configurations. Table 3 shows the 48-bit shift register bit assignment.

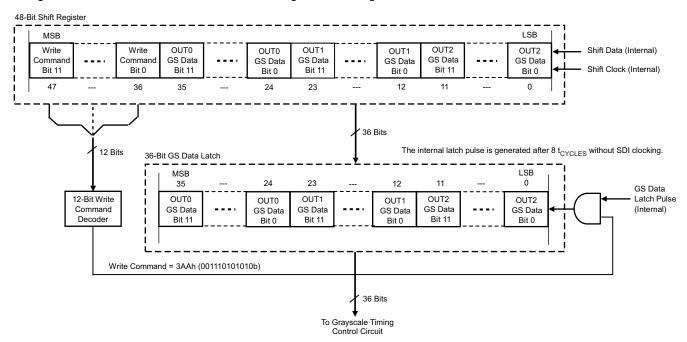


Figure 21. Common Shift Register and Control Data Latches Configuration

Table 3. 48-Bit Shift Register Data Bit Assignment

BITS	BIT NAME	CONTROLLED CHANNEL/FUNCTIONS
0 to 11	GSOUT2	GS data bits 0 to 11 for OUT2
12 to 23	GSOUT1	GS data bits 0 to 11 for OUT1
24 to 35	GSOUT0	GS data bits 0 to 11 for OUT0
36 to 47	WRTCMD	Data write command (3AAh) for GS data. The lower 36-bit GS data in the 48-bit shift register are copied to the GS data latch when the internal GS latch is generated (when these data bits are 3AAh, 001110101010b).

## 9 Applications and Implementation

#### 9.1 Application Information

The device is a constant sink current LED driver. This device is typically used to minimize wiring cost in applications and also provides no restrictions of cascading multiple devices in series. Furthermore, the device maximum data transfer rate is 3 Mbps and can contribute high-frequency display data change rates. The following design procedures can be used to maximize application design with minimal wiring cost. The device is also a good choice for higher VCC power-supply voltage applications because of the internal shunt regulator included in the device.

## 9.2 Typical Applications

## 9.2.1 No Internal Shunt Regulator Mode 1

This application does not use the shunt regulator. However, the device VCC and LED lamp anode voltage can be supplied from the same power supply because only one LED lamp is connected in series.

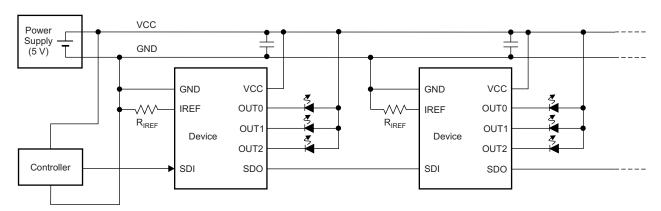


Figure 22. No Internal Shunt Regulator Mode 1 Typical Application Circuit

#### 9.2.1.1 Design Requirements

**Table 4. Design Parameters** 

DESIGN PARAMETER	EXAMPLE VALUE			
Input voltage range for VCC	3.0 V or LED forward voltage (V <sub>F</sub> ) + 1 V to 5.5 V			
SDI voltage range	Low level = GND, high level = VCC			
SDI data transfer rate	100 kbps to 3 Mbps			

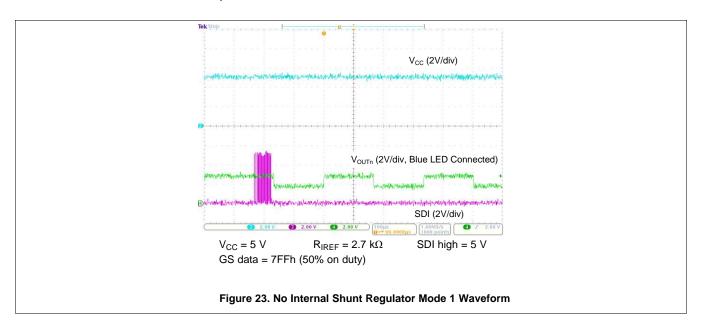
## 9.2.1.2 Detailed Design Procedure

The OUTn (n = 0 to 2) constant output current is set by an external resistor connected between the device IREF and GND pins. Use Equation 1 to calculate the requirements for  $R_{IREF}$ .



## 9.2.1.3 Application Curve

One LED is connected to each output.



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#### 9.2.2 No Internal Shunt Regulator Mode 2

This application does not use the shunt regulator. However, the device VCC and LED lamp anode voltage are supplied from different power supplies.

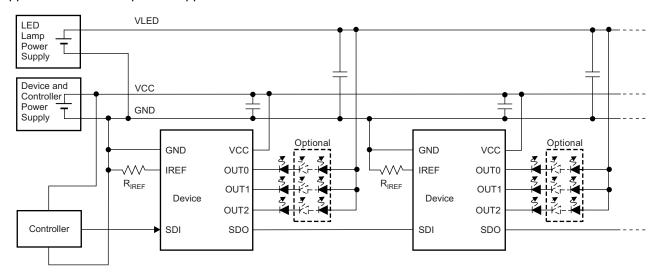


Figure 24. No Internal Shunt Regulator Mode 2 Typical Application Circuit

#### 9.2.2.1 Design Requirements

**Table 5. Design Parameters** 

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range for VCC	3.0 V to 5.5 V
Input voltage range for LED lamp	LED forward voltage (V <sub>F</sub> ) × the number of LED lamps + 1 V; maximum voltage is 24 V
SDI voltage range	Low level = GND, high level = VCC
SDI data frequency	100 kbps to 3 Mbps

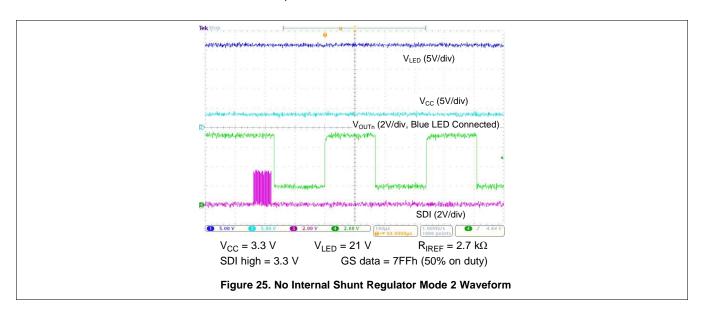
## 9.2.2.2 Detailed Design Procedure

The OUTn (n = 0 to 2) constant output current is set by an external resistor connected between the device IREF and GND pins. Use Equation 1 to calculate the requirements for  $R_{IREF}$ .



## 9.2.2.3 Application Curve

Six LEDs are connected in series to each output.





#### 9.2.3 Internal Shunt Regulator Mode

This application uses the shunt regulator. The device VCC and LED lamp anode voltage are supplied from the same power supply. At least two LED lamps are connected in series.

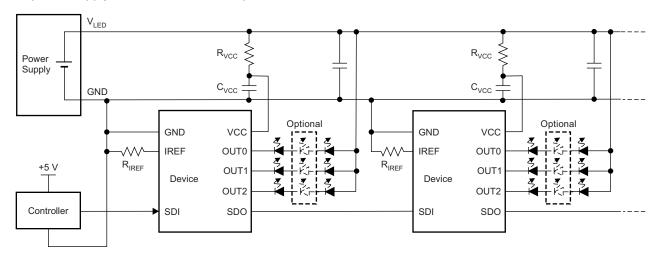


Figure 26. Internal Shunt Regulator Mode Typical Application Circuit

#### 9.2.3.1 Design Requirements

**Table 6. Design Parameters** 

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range for V <sub>LED</sub>	6 V to 24 V
SDI voltage range	Low level = GND, high level = 5.0 V to 6.0 V
SDI data transfer rate	100 kbps to 3 Mbps

## 9.2.3.2 Detailed Design Procedure

The TLC5973 internally integrates a shunt regulator to regulate  $V_{CC}$  voltage. Refer to Figure 27 for an application circuit that uses the internal shunt regulator through a resistor,  $R_{VCC}$ . The recommended  $R_{VCC}$  value can be calculated by Equation 2.

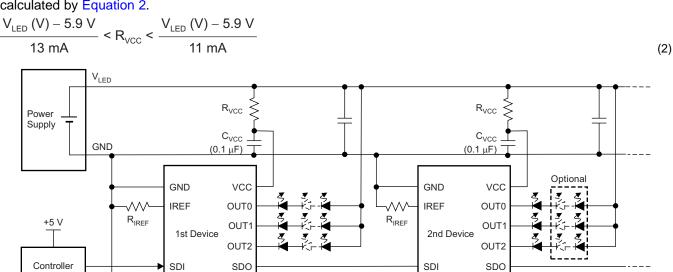


Figure 27. Internal Shunt Regulator Mode Application Circuit



Table 7 shows the typical resistor value for several  $V_{LED}$  voltages. Note that the  $C_{VCC}$  value should be 0.1  $\mu$ F.

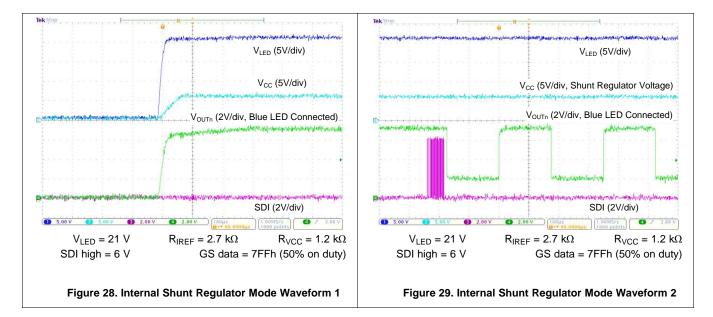
Table 7. Resistor Example for Shunt Resistor versus LED Voltage<sup>(1)</sup>

V <sub>LED</sub> (V)	R <sub>VCC</sub> (Ω)	RESISTOR WATTAGE (W)
9	270	0.04
12	510	0.07
18	1000	0.15
24	1500	0.22

<sup>(1)</sup>  $R_{IREF}$  is at 1.5 k $\Omega$ .

## 9.2.3.3 Application Curves

Six LEDs are connected in series to each output.





## 10 Power Supply Recommendations

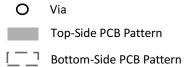
The power supply voltage should be well regulated. An electrolytic capacitor must be used to reduce the voltage ripple to less than 5% of the input voltage.

## 11 Layout

## 11.1 Layout Guidelines

- The resistor used for the output current setting should be placed near the IREF and GND pins of the device.
- The decoupling capacitor and the shunt regulator resistor should be placed near the VCC pin of the device.

## 11.2 Layout Example



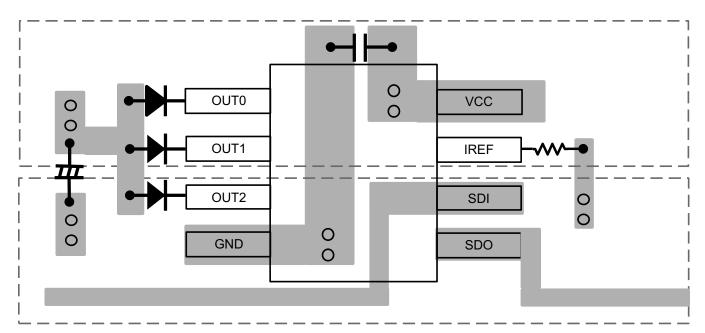


Figure 30. Layout Example



## 12 Device and Documentation Support

#### 12.1 Trademarks

EasySet is a trademark of Texas Instruments, Inc.
All other trademarks are the property of their respective owners.

### 12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 12.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 10-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material			Part marking (6)
						(4)	(5)		
TLC5973D	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5973
TLC5973D.B	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5973
TLC5973DR	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5973
TLC5973DR.B	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	5973

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

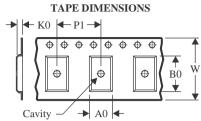
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

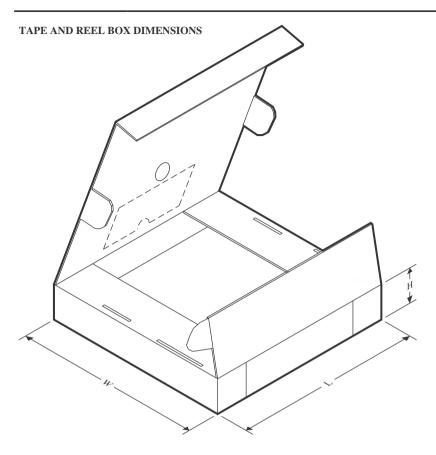


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC5973DR	SOIC	D	8	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 23-May-2025



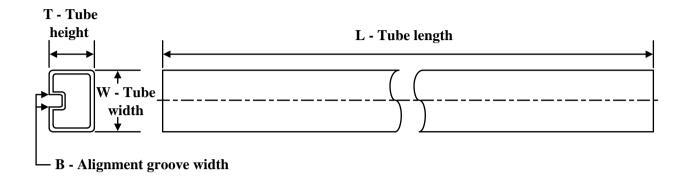
#### \*All dimensions are nominal

Ì	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
ı	TLC5973DR	SOIC	D	8	2500	353.0	353.0	32.0	

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 23-May-2025

## **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TLC5973D	D	SOIC	8	75	507	8	3940	4.32
TLC5973D.B	D	SOIC	8	75	507	8	3940	4.32



SMALL OUTLINE INTEGRATED CIRCUIT



## NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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